# MOSFET – Power, Single N-Channel 40 V, 0.63 mΩ, 433 A

#### **Features**

- Small Footprint (8x8 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- Power 88 Package, Industry Standard
- AEC-Q101 Qualified and PPAP Capable
- Wettable Flank Plated for Enhanced Optical Inspection
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

# MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	40	V
Gate-to-Source Voltage	Э		$V_{GS}$	±20	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	433	Α
Current R <sub>θJC</sub> (Notes 1, 3)	Steady	T <sub>C</sub> = 100°C		306	
Power Dissipation	State	T <sub>C</sub> = 25°C	$P_{D}$	205	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		103	
Continuous Drain	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	67	Α
Current R <sub>0JA</sub> (Notes 1, 2, 3)		T <sub>A</sub> = 100°C		47	
Power Dissipation		T <sub>A</sub> = 25°C	$P_{D}$	4.9	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C		2.5	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			I <sub>S</sub>	171	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 40 A)			E <sub>AS</sub>	1446	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

# THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.73	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	30.4	

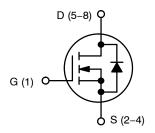
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface–mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
40 V	0.63 mΩ @ 10 V	433 A	
	0.92 m $\Omega$ @ 4.5 V	+00 <i>T</i> A	



**N-CHANNEL MOSFET** 



DFNW8 TX SUFFIX CASE 507AP

## MARKING DIAGRAM



XXX = Device Code

(8 A-N characters max)

A = Assembly Location

WL = 2-digit Wafer Lot Code

Y = Year Code

WW = Work Week Code

# ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D =$	250 μΑ	40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				13.8		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$	T <sub>J</sub> = 25 °C			10	
		V <sub>DS</sub> = 40 V	T <sub>J</sub> = 125°C			250	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.0		2.5	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-5.96		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		0.53	0.63	mΩ
		V <sub>DS</sub> = 4.5 V	I <sub>D</sub> = 50 A		0.76	0.92	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 5 V, I <sub>D</sub>	= 50 A		200		S
CHARGES, CAPACITANCES & GATE R	ESISTANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 25 V			12238		pF
Output Capacitance	C <sub>OSS</sub>				4629		
Reverse Transfer Capacitance	C <sub>RSS</sub>				129		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 20 \text{ V}; I_D = 50 \text{ A}$ $V_{GS} = 4.5 \text{ V}, V_{DS} = 20 \text{ V}; I_D = 50 \text{ A}$			99		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				18		
Gate-to-Source Charge	Q <sub>GS</sub>				31		
Gate-to-Drain Charge	$Q_{GD}$				32		
Plateau Voltage	$V_{GP}$				2.76		V
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 20 V; I <sub>D</sub> = 50 A			205		nC
SWITCHING CHARACTERISTICS (Note	5)						
Turn-On Delay Time	t <sub>d(ON)</sub>				31		
Rise Time	t <sub>r</sub>	VGS = 10 V. VD	e = 20 V.		29		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 20 \text{ V},$ $I_{D} = 50 \text{ A}, R_{G} = 6 \Omega$			227		ns
Fall Time	t <sub>f</sub>				58		
DRAIN-SOURCE DIODE CHARACTERIS	STICS						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.77	1.2	
		I <sub>S</sub> = 50 A	T <sub>J</sub> = 125°C		0.65		V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs, I <sub>S</sub> = 50 A			88.9		
Charge Time	ta				48.8		ns
Discharge Time	t <sub>b</sub>				40.1		1
Reverse Recovery Charge	Q <sub>RR</sub>				184		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

5. Switching characteristics are independent of operating junction temperatures.

### **TYPICAL CHARACTERISTICS**

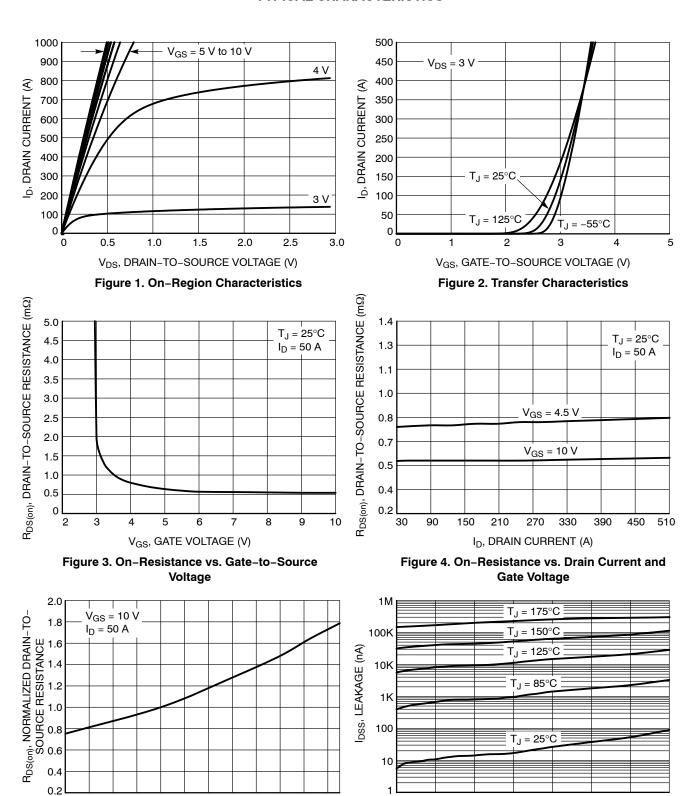


Figure 5. On–Resistance Variation with Temperature

T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

-55 -35 -15

5 25 45 65 85

Figure 6. Drain-to-Source Leakage Current vs. Voltage

V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (V)

25

30

35

40

20

15

105 125 145 165

### **TYPICAL CHARACTERISTICS**

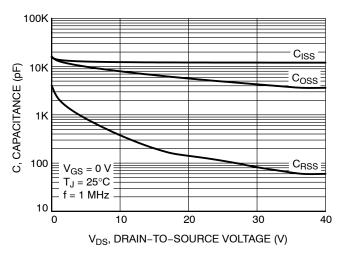


Figure 7. Capacitance Variation

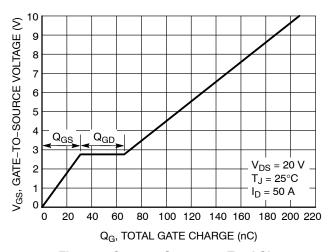


Figure 8. Gate-to-Source vs. Total Charge

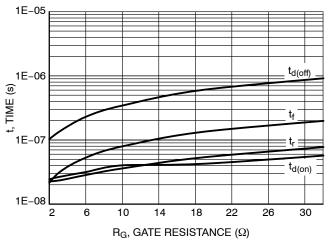


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

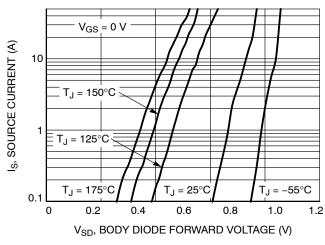


Figure 10. Diode Forward Voltage vs. Current

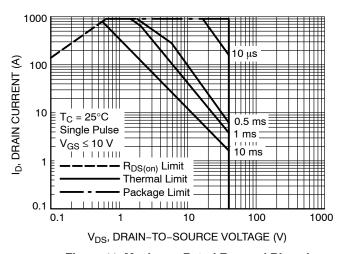


Figure 11. Maximum Rated Forward Biased Safe Operating Area

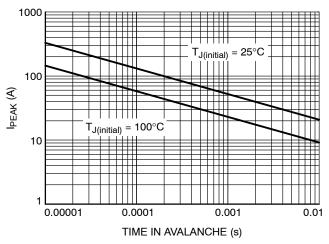


Figure 12. Maximum Drain Current vs. Time in Avalanche

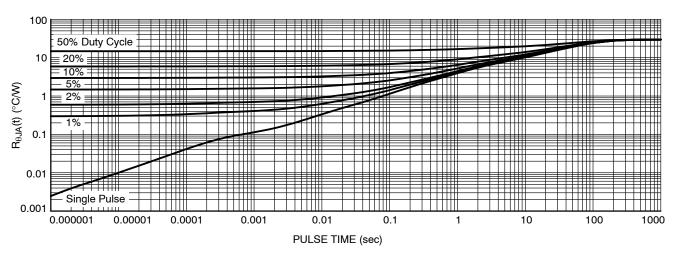
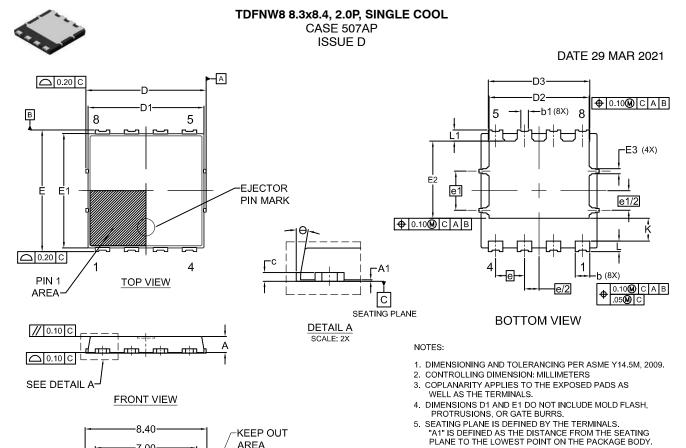


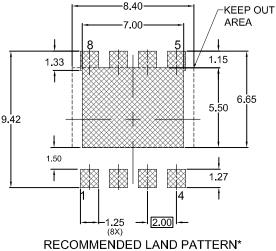
Figure 13. Thermal Response

# **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVMTS0D7N04CLTXG	0D7N04CL	POWER 88 (Pb-Free)	3000 / Tape & Reel

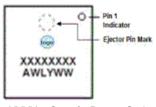
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

# GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code
A = Assembly Location
WL = Wafer Lot Code
Y = Year Code
WW = Work Week Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ", may or may not be present. Some products may not follow the Generic Marking.

DIM	MILLIMETERS			
DIW	MIN. NOM.		MAX.	
Α	1.00	1.10	1.20	
A1	0.00	ļ	0.05	
b	0.90	1.00	1.10	
b1	0.35	0.45	0.55	
C	0.23	0.28	0.33	
О	8.20	8.30	8.40	
D1	7.90	8.00	8.10	
D2	6.80	6.90	7.00	
D3	6.90	7.00	7.10	
Е	8.30	8.40	8.50	
E1	7.80	7.90	8.00	
E2	5.24	5.34	5.44	
E3	0.25	0.35	0.45	
е	2.00 BSC			
e/2	1.00 BSC			
e1	2.70 BSC			
e1/2	1.35 BSC			
K	1.50	1.57	1.70	
L	0.64	0.74	0.84	
L1	0.67	0.77	0.87	
Ф	0°		12°	

DESCRIPTION	TDFNW8 8.3x8.4, 2.0P, SIN		PAGE 1 OF 1	
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